## Supporting information



**Figure S1**: Components used for analyzing X-ray diffraction of thio-LICISON samples. The open type anode cap was covered with X-ray film (Mylar, XF-125, USA) resulting in the refl ections of the sample holder at 26°, 44°, and 52° in the X-ray diffraction pattern.



**Figure S2**: Equivalent circuit model for fitting the impedance plots obtained during ionic con ductivity measurement. The R and Q represent the resistance and constant phase elements. Th e  $Q_L$  denotes the low frequency tail of the impedance plot.<sup>S1</sup>

S1 H. Xie, J. B. Goodenough and Y. Lib, J. Power Sources, 2011, 196, 7760-7762.